FDS3590

80V N-Channel PowerTrench® MOSFET

General Description

SEMICONDUCTOR IM

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{\text{DS}(\text{ON})}$ specifications.

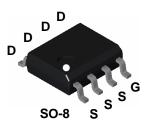
The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

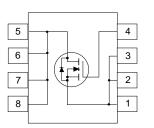
Features

• 6.5 A, 80 V
$$R_{DS(ON)} = 39 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$$

 $R_{DS(ON)} = 44 \text{ m}\Omega @ V_{GS} = 6 \text{ V}$

- Low gate charge
- Fast switching speed
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		80	V
V _{GSS}	Gate-Source Voltage		±20	V
ID	Drain Current – Continuous	(Note 1a)	6.5	A
	– Pulsed		50	
PD	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.2	
		(Note 1c)	1.0	
T_{J},T_{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C
Therma	I Characteristics			
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDS3590	FDS3590	13"	12mm	2500 units

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FDS3590

WDSS S A A IAR M Off Charac BVDSS D <u>ABVDSS</u> B	rce Avalanche Ratings (Not ingle Pulse Drain-Source valanche Energy laximum Drain-Source valanche Current	te 2) V _{DD} = 40 V, I _D = 6.5 A			475	
WDSS S A A IAR M Off Charac BVDSS D <u>ABVDSS</u> B	ingle Pulse Drain-Source valanche Energy laximum Drain-Source valanche Current				475	
I _{AR} M A Off Charac BV _{DSS} D ΔBV _{DSS} B	laximum Drain-Source valanche Current			1	175	mJ
A Off Charac BV _{DSS} D <u>ABV_{DSS}</u> B	valanche Current				6.5	А
BV _{DSS} D					0.5	~
ABV _{DSS} B	teristics					
	rain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	80			V
ΔT _J C	reakdown Voltage Temperature coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		88		mV/°C
I _{DSS} Z	ero Gate Voltage Drain Current	$V_{DS} = 64 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA
I _{GSSF} G	ate-Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
I _{GSSR} G	ate–Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			-100	nA
On Charac	teristics (Note 2)					
	Sate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	1	4	V
	ate Threshold Voltage	$I_D = 250 \mu$ A, Referenced to 25° C		-6		mV/°C
Ŷ	emperature Coefficient				'	
20(01)	tatic Drain–Source In–Resistance	$V_{GS} = 10 \text{ V}, I_D = 6.5 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 6.5 \text{ A}, \text{ T}_J = 125^{\circ}\text{C}$		32 61	39 86	mΩ
	II-Resistance			34	44	1
I _{D(on)} C	n-State Drain Current		25			Α
G _{FS} F	orward Transconductance	$V_{GS} = 10 \text{ V}, I_D = 6.5 \text{ A}$		25		S
Dynamic C	Characteristics					
	put Capacitance	$V_{DS} = 40 V$, $V_{GS} = 0 V$,		1180		pF
	Dutput Capacitance	f = 1.0 MHz		171		pF
	everse Transfer Capacitance	-		50		pF
Switching	Characteristics (Note 2)	I			1	1
	urn–On Delay Time	$V_{DD} = 40 V, I_D = 1 A,$		11	20	ns
t _r T	urn–On Rise Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		8	16	ns
t _{d(off)} T	urn–Off Delay Time	-		26	50	ns
t _f T	urn–Off Fall Time	-		12	25	ns
	otal Gate Charge	$V_{DS} = 40 V$, $I_D = 6.5 A$,		25	35	nC
	ate–Source Charge	V _{GS} = 10 V		4.5		nC
	ate–Drain Charge	-	-	5.8		nC
Drain Sou	roo Diado Charactoristico	and Maximum Patings		<u> </u>		
	rce Diode Characteristics			, I I I I I I I I I I I I I I I I I I I	2.1	А
	rain-Source Diode Forward	$V_{GS} = 0 V, I_S = 2.1 A$ (Note 2)		0.74	1.2	V

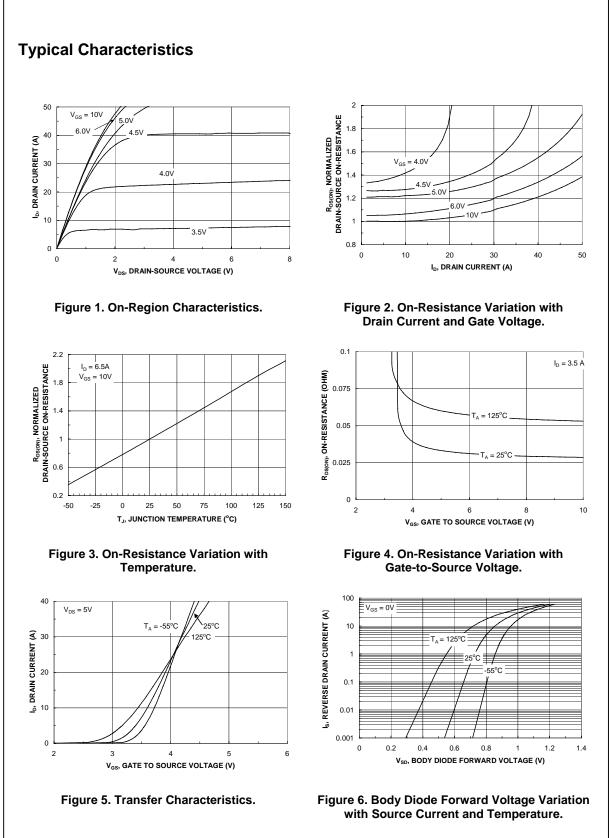


a) 50 °C/W when mounted on a 1in² pad of 2 oz copper b) 105 °C/W when mounted on a 0.04 in² pad of 2 oz copper c) 125 °C/W when mounted on a minimum pad.

FDS3590 Rev C. (W)

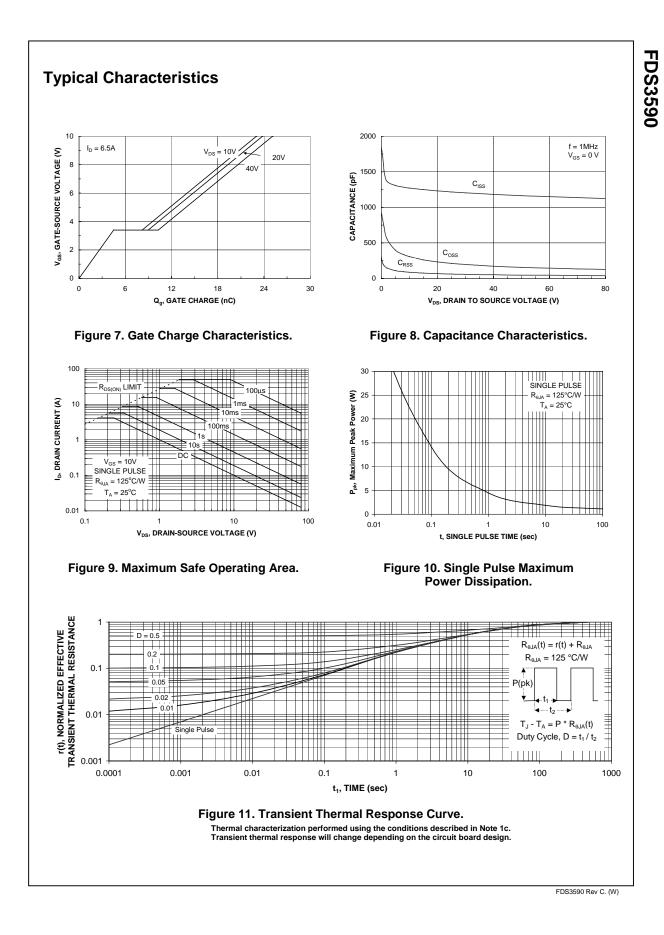
Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%



FDS3590

FDS3590 Rev C. (W)



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Datasheet Identification	Product Status	Definition
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